

<b>Notice of References Cited</b>	Application/Control No. 10/784,273		Applicant(s)/Patent Under Reexamination OBAYASHI ET AL.	
	Examiner Eric Liou		Art Unit 3628	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,201,312	03-2001	Shioiri et al.	290/40C
*	B	US-5,704,440	01-1998	Urban et al.	180/65.2
*	C	US-5,839,533	11-1998	Mikami et al.	180/165
*	D	US-6,209,672	04-2001	Severinsky, Alex J.	180/65.2
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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